

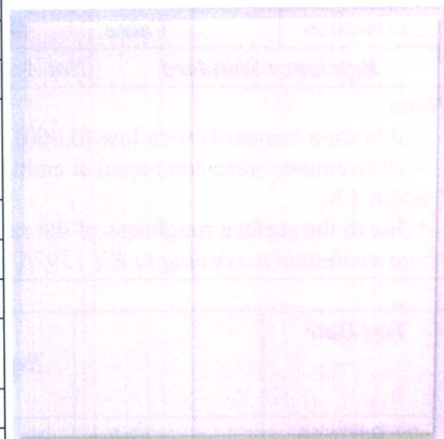
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GENERAL INFORMATION

Subject:	Test report on testing activities to determine solar reflectance, infrared emittance and solar reflectance index (SRI).		
Client	AMA Composites Srl Via Repubblica 7 42011 Campogalliano (MO) P.IVA: 02905040362	Client reference person	Marco Corradini Phone +39.059.851754 Email info@amacomposites.it
Commitment document	-	Report release date	22/04/2016

SAMPLE DATA

Receipt date	01/03/2016		
Sample id. sub.	-		
ECRC id	-		
Manufacturer	-		
Product name	Thermogel Metal		
Sampling	Supplied by the Client		
Short physical description*	Product type: aerogel water based enamel, for metal surfaces, with heat reflecting properties Substrate: Metal sheet		
Sample thickness	1.3 mm	Total sample size	300 x 210 mm
Surface coated	YES	Coating thickness	N.A.
Surface state	<i>variegated</i> NO	<i>aged</i> NO	<i>cleaned</i> NO
Information on history and ageing*	N.A.		
Optical properties	Diffusive reflecting	NO	
	Specular reflecting	NO	
	Intermediate reflecting	YES	
	Clear transmitting	NO	
	Translucent transmitting	NO	
	Opaque	YES	
Notes	Information on surface coating, aging and cleaning provided by the Client where known.		



Sample picture

The test results are based on the material supplied by the client. This report shall not be reproduced except in full without the written approval of this laboratory. This laboratory assumes no responsibility nor makes a performance or warranty statement for this material or products and processes containing this material in connection with this report.

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TEST RESULTS

Test Date		Solar Reflectance (SR)	Standard Deviation	Measured Values		
7/03/2016	Value	0.865	0.001	0.865	0.866	0.865
Reference Standard		ASTM C1549-09				
Reference Solar Spectrum		ASTM Standard G173 Hemispherical Tilt				

Notes

This test was performed according to *ASTM C1549-09: Standard Test Method for Determination of Solar Reflectance Near Ambient Temperature Using a Portable Reflectometer* with air mass 1.5. A solar spectrum reflectometer Devices and Services SSR-ER was used. Calibration standards with low (0.000) and high (0.864) solar reflectance were provided by the instrument manufacturer. Measurements were conducted at ambient temperature of $22 \pm 4^\circ\text{C}$ and relative humidity of $41\% \pm 10\%$.

Test Date		Infrared Emittance (IE)	Standard Deviation	Measured Values				
21/04/2016	Value	0.908*	0.004	0.912	0.913	0.906	0.904	0.907
Reference Standard		Not Accredited Slide Method- Not Accredited EN 15976						

Notes

Calibration standards with low (0.060) and high (0.870) emittance were provided by the instrument manufacturer. Measurements were conducted at ambient temperature of $22 \pm 4^\circ\text{C}$ and relative humidity of $41\% \pm 10\%$ in a time period of about 1 h. *Due to the surface roughness of the sample, it was not possible to measure IE according to *ASTM C1371: Thermal Emittance was evaluated according to EN 15976, non-accredited method.*

Test Date		Solar Reflectance (SR)	Infrared Emittance (IE)	Solar Reflectance Index (SRI) [%]		
				Low wind	Medium wind	High Wind
21/04/2016	Value	0.865	0.908*	110.4	109.4	108.9
				Surface temperature (ST) [°C]		
Reference Standard		ASTM E1980-11*				

Notes

This calculation was performed according to *ASTM E1980-11: Standard Practice for Calculating Solar Reflectance Index of Horizontal and Low-Sloped Opaque Surfaces*. This utilizes the following values for the convection coefficient: $h_c = 5 \text{ W/m}^2\cdot\text{K}$ for low-wind (0 to 2 m/s), $h_c = 12 \text{ W/m}^2\cdot\text{K}$ for medium-wind (2 to 6 m/s), and $h_c = 30 \text{ W/m}^2\cdot\text{K}$ for high-wind (6 to 10 m/s). *Since it was not possible to measure IE according to *ASTM C1371, Thermal Emittance was evaluated according to EN 15976, non-accredited method.*

The Responsible of EELab Laboratory
Prof. Alberto Muscio

